## **AMENDMENTS**

## CLAIMS:

- 1. (Currently Amended) A method for topographical patterning of a device, the method comprising the steps of:
- (a) positioning a mask relative to the device, the mask being in the form of a pattern, wherein the mask exposes a surface of the device; and
- (b) etching the pattern into a surface of the device to form a feature, wherein said feature includes at least three one sidewalls and a rounded edge between the surface of on the device and one all of the at least three sidewalls in the feature pattern.
- 2. (Currently Amended) The method of claim 1 wherein the rounded edge is an arcuate edge and extends along one of the at least one three sidewalls in the feature pattern of the device.
- 3. (Original) The method of claim 1 wherein the etching step (b) forms an opening in the device.
- 4. (Original) The method of claim 3 further comprising a step of (c) inserting a mating element into the opening on the device such that the rounded edge formed during the etching step (b) permits the mating element to be inserted into the opening without fracturing the device.
- 5. (Currently Amended) The method of claim 1 wherein the etching step (b) forms an island on the device, the at least one three sidewalls located on an edge of the island.
- 6. (Original) The method of claim 1 wherein the pattern of the mask is formed with variable spacings to produce the rounded edge.

- 7. (Original) The method of claim 1 wherein the pattern of the mask is formed with spacings that are closer together near the surface of the device and more widely spaced near the sidewall.
- 8. (Original) The method of claim 7 wherein the spacings in the pattern of the mask are varied to vary the rounded shape.
- 9. (Currently Amended) The method of claim 8 wherein the spacings in the pattern of the mask are graduated from a largest spacing near one of the at least three sidewalls to a smallest spacing near the surface.
- 10. (Withdrawn) The method of claim 1 wherein the etching step (b) comprises immersing the device within a liquid.
- 11. (Withdrawn) The method of claim I wherein the etching step (b) comprises spraying a liquid against the surface of the device.
- 12. (Withdrawn) The method of claim 1 wherein the etching step (b) comprises exposing the surface of the device to a vapor.
- 13. (Withdrawn) The method of claim 1 wherein the etching step (b) comprises exposing the surface of the device to a plasma.
- 14. (Original) The method of claim 1 wherein the etching step (b) comprises directing an ion beam at the surface of the device.
- 15. (Original) The method of claim 14 wherein material in the ion beam chemically reacts with material at the surface of the device.
- 16. (Withdrawn) The method of claim 1 wherein the etching step (b) comprises directing a stream of electrons at the surface of the device.

17. (Withdrawn) The method of claim 1 wherein the etching step (b) comprises directing Xrays at the surface of the device.

SEAGATE

- 18. (Original) The method of claim 1 wherein the positioning step (a) comprises applying the mask to the surface of the device.
- 19. (Original) The method of claim 1 wherein the device comprises more than one layer and the etching step (b) comprises etching into one or more of the layers.
- 20. (Cancelled)
- 21. (Original) The method of claim 1 wherein the device is a slider for a disc drive.
- 22-30. (Cancelled)